Se	arci	ch Notes		

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/731,722	TRAN ET AL.	
Examiner	Art Unit	
David Sample	1755	

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Class	Subclass ·	Date	Examiner
423	700	9/22/2006	DAI
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INTERFERENCE SEARCHED				
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423	720,037	9/2/07	15>	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East searched	9/22/2008	SU
STN file CA searched	9/22/2008	W
Inventor name PALM search	9/22/2006	OSSI
clan inautorname search	9/20/07	03
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